

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/797,188	EMA ET AL.	
Examiner	Art Unit	
Lynette T. Umez-Eronini	1765	

SEARCHED				
Class	Subclass	Date	Examiner	
438	689	12/15/2006	LTUE	
438	692	12/15/2006	LTUE	
438	703	12/15/2006	LTUE	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH N (INCLUDING SEARC)
	DATE	EXMR
EAST (Inventors' search)	12/15/2006	LTUE
EAST (Inventors' search)	12/18/2006	LTUE
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